

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10698666	HUSTED, PAUL J.
	Examiner Lee, Siu M	Art Unit 2611

SEARCHED

Class	Subclass	Date	Examiner
375	341, 345, 262, 137, 355, 316, 340, 260, 343, 365, 346, 368, 234, 324, 347, 130	3/7/2007	Siu M. Lee

SEARCH NOTES

Search Notes	Date	Examiner
EAST	3/7/2007	Siu M. Lee
Discuss application with Chieh Fan	3/12/2007	Siu M. Lee

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner